

# STGF19NC60WD

## N-channel 600V - 7A - TO-220 Ultra fast PowerMESH™ IGBT

#### PRELIMINARY DATA

### Features

Туре	V <sub>CES</sub>	V <sub>CE(sat)</sub> (max)@25°C	l <sub>C</sub> @100°C
STGF19NC60WD	600V	< 2.5V	7A

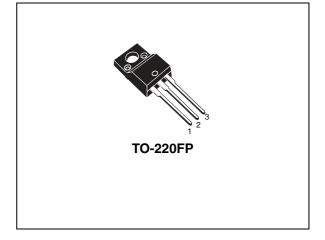
- High frequency operation
- Low C<sub>RES</sub> / C<sub>IES</sub> ratio (no cross-conduction susceptibility)
- Very soft ultra fast recovery antiparallel diode

## Description

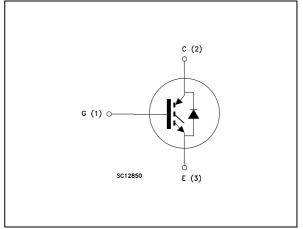
Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH™ IGBTs, with outstanding performances. The suffix "W" identifies a family optimized for very high frequency application.

## Applications

- High frequency motor controls, inverters, UPS
- HF, SMPS and PFC in both hard switch and resonant topologies



### Internal schematic diagram



### Order code

Part number	Marking	Package	Packaging
STGF19NC60WD	GF19NC60WD	TO-220	Tube

## Contents

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# 1 Electrical ratings

Table 1.	Absolute maximum ratings
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Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-emitter voltage (V <sub>GS</sub> = 0)	600	V
I <sub>C</sub> <sup>(1)</sup>	Collector current (continuous) at $T_C = 25^{\circ}C$	14	А
I <sub>C</sub> <sup>(1)</sup>	Collector current (continuous) at $T_C = 100^{\circ}C$	7	А
I <sub>CL</sub> <sup>(2)</sup>	Collector current (pulsed)	35	А
١ <sub>F</sub>	Diode RMS forward current at $T_C = 25^{\circ}C$	12	A
V <sub>GE</sub>	Gate-emitter voltage	±20	V
P <sub>TOT</sub>	Total dissipation at $T_{C} = 25^{\circ}C$	32	W
T <sub>stg</sub>	Storage temperature	– 55 to 150	°C
Тj	Operating junction temperature		Ŭ

1. Calculated according to the iterative formula:

$$C^{(T_{C})} = \frac{T_{JMAX}^{-T_{C}}}{R_{THJ-C} \times V_{CESAT(MAX)}^{(T_{C}, I_{C})}}$$

2. Vclamp=480V, Tj=150°C,  $R_G$ =10Ω,  $V_{GE}$ =15V

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case max	4	°C/W
Rthj-amb	Thermal resistance junction-ambient max	62.5	°C/W

## 2 Electrical characteristics

(T<sub>CASE</sub>=25°C unless otherwise specified)

Table 3.	Static
	Otatic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>BR(CES)</sub>	Collector-emitter breakdown voltage	I <sub>C</sub> = 1mA, V <sub>GE</sub> = 0	600			V
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 12A V <sub>GE</sub> = 15V, I <sub>C</sub> =12A,Tc=125°C		2.1 1.8	2.5	V V
V <sub>GE(th)</sub>	Gate threshold voltage	$V_{CE} = V_{GE}$ , $I_C = 250 \ \mu A$	3.75		5.75	V
I <sub>CES</sub>	Collector cut-off current (V <sub>GE</sub> = 0)	V <sub>CE</sub> = Max rating,T <sub>C</sub> = 25°C V <sub>CE</sub> = Max rating,T <sub>C</sub> = 125°C			150 1	μA mA
I <sub>GES</sub>	Gate-emitter leakage current (V <sub>CE</sub> = 0)	$V_{GE}$ = ±20V, $V_{CE}$ = 0			±100	nA
9 <sub>fs</sub>	Forward transconductance	$V_{CE} = 15V_{,} I_{C} = 12A$		10		S

### Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>ies</sub> C <sub>oes</sub> C <sub>res</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>CE</sub> = 25V, f = 1MHz, V <sub>GE</sub> = 0		1180 130 26		pF pF pF
Q <sub>g</sub> Q <sub>ge</sub> Q <sub>gc</sub>	Total gate charge Gate-emitter charge Gate-collector charge	$V_{CE}$ = 390V, I <sub>C</sub> = 5A, $V_{GE}$ = 15V, <i>Figure 16</i>		53 10 21		nC nC nC

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> (di/dt) <sub>on</sub>	Turn-on delay time Current rise time Turn-on current slope	$V_{CC}$ = 390V, I <sub>C</sub> = 12A R <sub>G</sub> = 10 $\Omega$ , V <sub>GE</sub> = 15V, <i>Figure 17</i>		25 7 1600		ns ns A/µs
t <sub>d(on)</sub> t <sub>r</sub> (di/dt) <sub>on</sub>	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390V, I_C = 12A$ $R_G = 10\Omega, V_{GE} = 15V,$ $Tj = 125^{\circ}C$ <i>Figure 17</i>		25 8 1400		ns ns A/µs
t <sub>r</sub> (V <sub>off</sub> ) t <sub>d</sub> ( <sub>off</sub> ) t <sub>f</sub>	Off voltage rise time Turn-off delay time Current fall time	$V_{CC}$ = 390V, I <sub>C</sub> = 12A R <sub>G</sub> = 10 $\Omega$ , V <sub>GE</sub> = 15V, <i>Figure 17</i>		22 90 43		ns ns ns
t <sub>r</sub> (V <sub>off</sub> ) t <sub>d</sub> ( <sub>off</sub> ) t <sub>f</sub>	Off voltage rise time Turn-off delay time Current fall time	$V_{CC} = 390V, I_C = 12A$ $R_G = 10\Omega, V_{GE} = 15V,$ $Tj = 125^{\circ}C$ <i>Figure 17</i>		47 127 77		ns ns ns

 Table 5.
 Switching on/off (inductive load)

 Table 6.
 Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
E <sub>on</sub> <sup>(1)</sup> E <sub>off</sub> <sup>(2)</sup> E <sub>ts</sub>	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC}$ = 390V, I <sub>C</sub> = 12A R <sub>G</sub> = 10 $\Omega$ , V <sub>GE</sub> = 15V, <i>Figure 17</i>		81 125 206		μJ μJ μJ
E <sub>on</sub> <sup>(1)</sup> E <sub>off</sub> <sup>(2)</sup> E <sub>ts</sub>	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390V, I_C = 12A$ $R_G = 10\Omega, V_{GE} = 15V,$ $Tj = 125^{\circ}C$ <i>Figure 17</i>		161 255 416		μJ μJ μJ

 Eon is the turn-on losses when a typical diode is used in the test circuit in *Figure 15* If the IGBT is offered in a package with a co-pak diode, the co-pack diode is used as external diode. IGBTs & Diode are at the same temperature (25°C and 125°C)

2. Turn-off losses include also the tail of the collector current



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>f</sub>	Forward on-voltage	I <sub>f</sub> = 12A I <sub>f</sub> = 12A, Tj = 125°C		1.9 1.5	2.5	V V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>rrm</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>f</sub> = 12A,V <sub>R</sub> = 50V, Tj = 25°C, di/dt = 100 A/μs <i>Figure 18</i>		31 30 2		ns nC A
t <sub>rr</sub> Q <sub>rr</sub> I <sub>rrm</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>f</sub> = 12A,V <sub>R</sub> = 50V, Tj =125°C, di/dt = 100A/μs <i>Figure 18</i>		59 102 4		ns nC A

 Table 7.
 Collector-emitter diode



### 2.1 Electrical characteristics (curves)

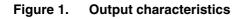


Figure 2. Transfer characteristics

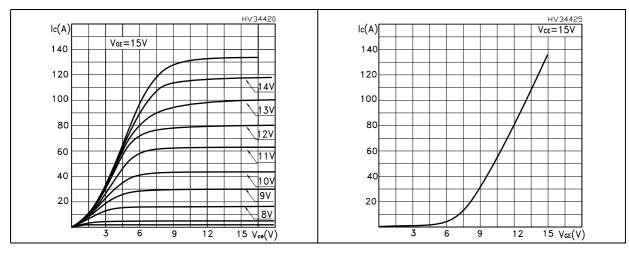




Figure 4. Collector-emitter on voltage vs temperature

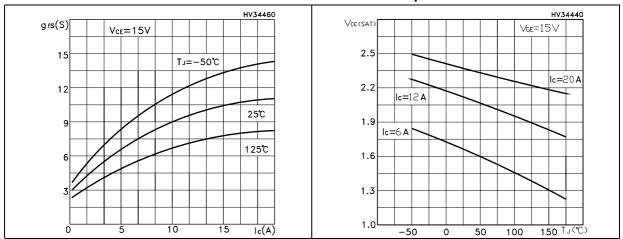
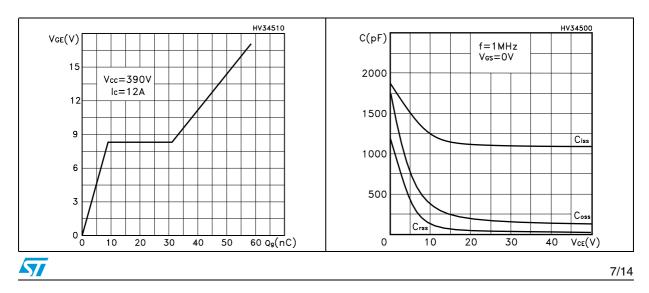
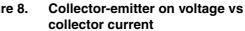


Figure 5. Gate charge vs gate-source voltage Figure 6. Capacitance variations



# Figure 7. Normalized gate threshold voltage Figure 8. vs temperature



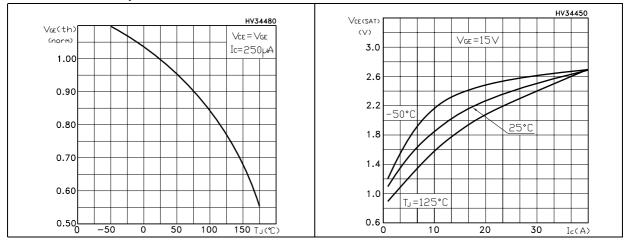


Figure 9. Normalized breakdown voltage vs Figure 10. Switching losses vs temperature temperature

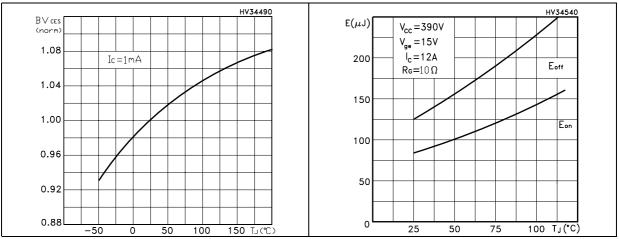
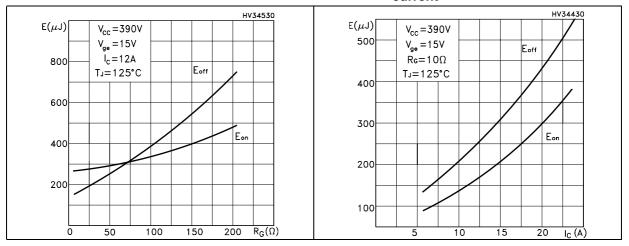


Figure 11. Switching losses vs gate resistance Figure 12. Switching losses vs collector current





### Figure 13. Turn-off SOA

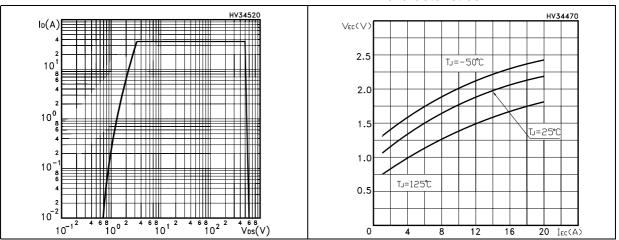


Figure 14. Emitter-collector diode characteristics



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## 3 Test circuit

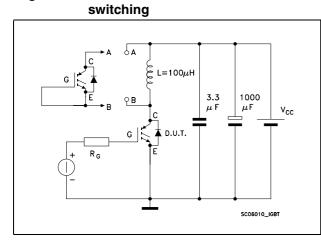
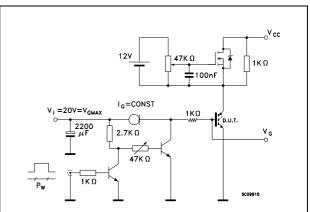
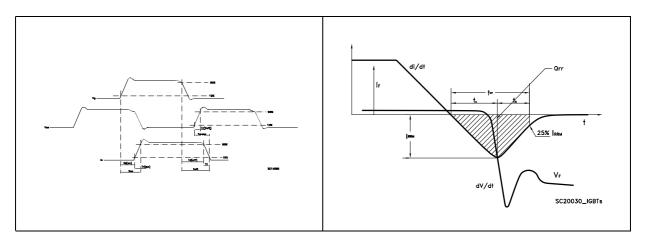


Figure 15. Test circuit for inductive load

Figure 17. Switching waveform







#### Figure 16. Gate charge test circuit

## 4 Package mechanical data

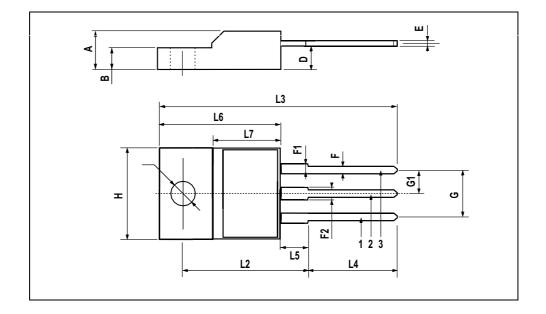
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: *www.st.com* 



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DIM.	mm.			inch		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
E	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.7	0.045		0.067
F2	1.15		1.7	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126

#### **TO-220FP MECHANICAL DATA**



# 5 Revision history

Table 8.Revision history

Date	Revision	Changes
13-Oct-2006	1	Initial release.
08-May-2007 2		Corrected value on Table 1, Table 2



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